


<b>Search Notes</b>  	<b>Application/Control No.</b>  10543167	<b>Applicant(s)/Patent Under Reexamination</b>  WIEMANN ET AL.
	<b>Examiner</b>  SHAQ TAHA	<b>Art Unit</b>  2446

SEARCHED			
Class	Subclass	Date	Examiner
709	223	01/08/2009	S. Taha

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/225,226,227,235,245 and cls 370/230	01/08/2009	S. Taha

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--